## **Power MOSFET** 60 V, 39 mΩ, 17 A, Dual N–Channel, Logic Level, Dual SO8FL

## Features

- Small Footprint (5x6 mm) for Compact Designs
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- 175°C Operating Temperature
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

## **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

			,			
Parar	neter		Symbol	Value	Unit	
Drain-to-Source Voltage		V <sub>DSS</sub>	60	V		
Gate-to-Source Voltage		V <sub>GS</sub>	±20	V		
Continuous Drain Cur-		T <sub>mb</sub> = 25°C	Ι <sub>D</sub>	17	А	
rent R <sub>ΨJ-mb</sub> (Notes 1, 2, 3, 4)	Steady	$T_{mb} = 100^{\circ}C$		12		
Power Dissipation	State	T <sub>mb</sub> = 25°C	PD	23	W	
$R_{\Psi J-mb}$ (Notes 1, 2, 3)		$T_{mb} = 100^{\circ}C$		12		
Continuous Drain Cur- rent $R_{\theta JA}$ (Notes 1 & 3, 4) Power Dissipation $R_{\theta, JA}$ (Notes 1, 3)		T <sub>A</sub> = 25°C	Ι <sub>D</sub>	6	А	
	Steady State	T <sub>A</sub> = 100°C		5		
		T <sub>A</sub> = 25°C	PD	3.2	W	
$R_{\theta JA}$ (Notes 1, 3)		T <sub>A</sub> = 100°C		1.6		
Pulsed Drain Current	T <sub>A</sub> = 25	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	74	А	
Operating Junction and	Storage T	emperature	T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C	
Source Current (Body D	iode)		IS	19	А	
Single Pulse Drain- to-Source Avalanche	(I <sub>L(pk)</sub> = 14.5 A, L = 0.1 mH)		E <sub>AS</sub>	10.5	mJ	
Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 24 V, V <sub>GS</sub> = 10 V, R <sub>G</sub> = 25 Ω)	(I <sub>L(pk)</sub> = 6.3 A, L = 2 mH)			40		
Lead Temperature for S (1/8" from case for 10 s)		Purposes	ΤL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Note 2, 3)	$R_{\PsiJ-mb}$	6.5	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Psi  $(\Psi)$  is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.

3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

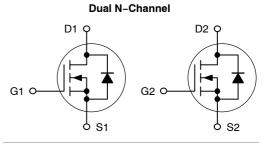
4. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

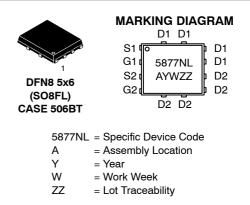


## **ON Semiconductor®**

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
60 V	39 mΩ @ 10 V	17 A
60 V	60 mΩ @ 4.5 V	17.7





#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NVMFD5877NLT1G	DFN8 (Pb-Free)	1500/Tape & Reel
NVMFD5877NLT3G	DFN8 (Pb-Free)	5000/Tape & Reel

+ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

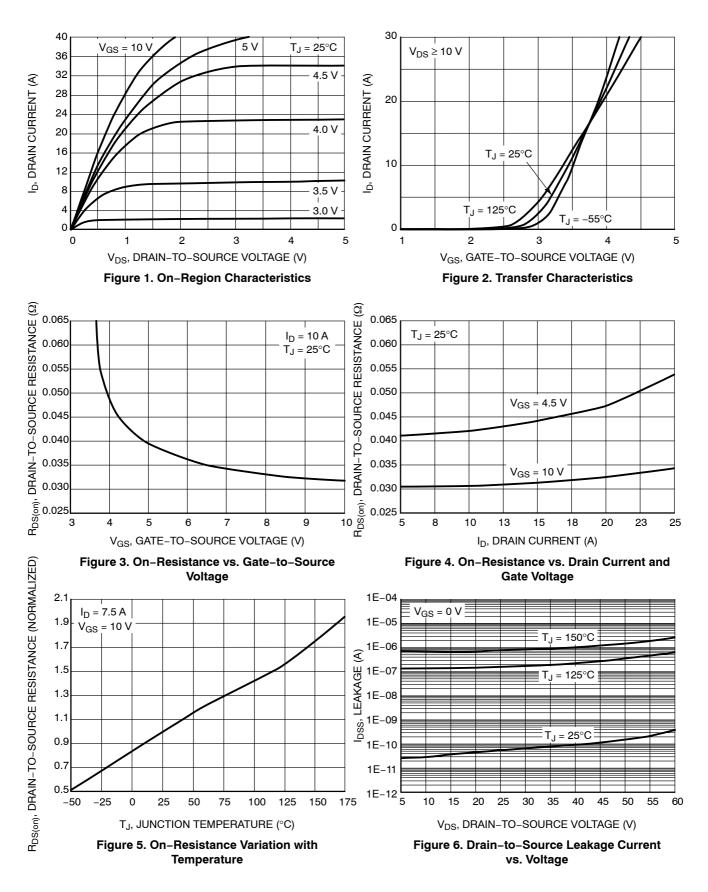
Semiconductor Components Industries, LLC, 2013	

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

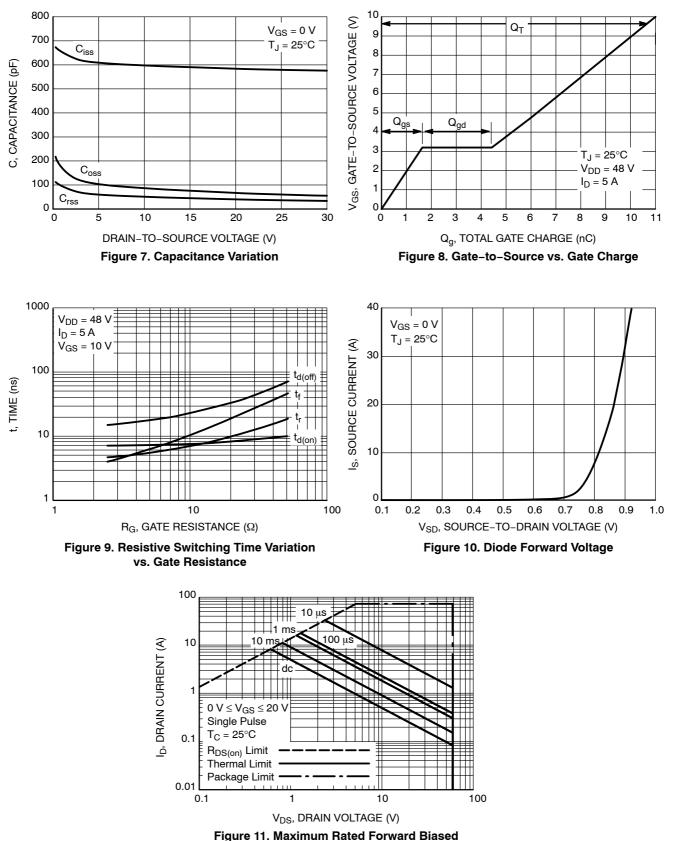
Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> =	250 μA	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				53		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{DS} = 60 V$	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μA	1.0	İ.	3.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				3.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 7.5 A		31	39	mΩ
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 7.5 A		42	60	1
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub>	= 5.0 A		7.0		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>				540		pF
Output Capacitance	C <sub>oss</sub>	$V_{GS}$ = 0 V, f = 1.0 MHz, $V_{DS}$ = 25 V			55		1
Reverse Transfer Capacitance	C <sub>rss</sub>				36		
Total Gate Charge	Q <sub>G(TOT)</sub>				5.9		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>D</sub>	<sub>S</sub> = 48 V,		0.62		1
Gate-to-Source Charge	Q <sub>GS</sub>	$I_{\rm D} = 5.0 \rm{A}$			1.64		1
Gate-to-Drain Charge	Q <sub>GD</sub>				2.80		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 4	8V, I <sub>D</sub> = 5.0A		11	20	nC
SWITCHING CHARACTERISTICS (No	ote 6)		-			-	-
Turn-On Delay Time	t <sub>d(on)</sub>				8.1		ns
Rise Time	t <sub>r</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 48 V, $I_{D}$ = 5.0 A, $R_{G}$ = 2.5 $\Omega$			15.8		
Turn-Off Delay Time	t <sub>d(off)</sub>				11.8		1
Fall Time	t <sub>f</sub>				3.9		1
Turn-On Delay Time	t <sub>d(on)</sub>				4.9		ns
Rise Time	tr	V <sub>GS</sub> = 10 V, V <sub>D</sub>	<sub>3</sub> = 48 V,		6.4		
Turn-Off Delay Time	t <sub>d(off)</sub>	I <sub>D</sub> = 5.0 A, R <sub>G</sub>	= 2.5 Ω		14.5		_
Fall Time	t <sub>f</sub>				2.4		
DRAIN-SOURCE DIODE CHARACTE	ERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.8	1.2	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 5.0 A	T <sub>J</sub> = 125°C		0.7		
Reverse Recovery Time	t <sub>RR</sub>		•		14.5		ns
Charge Time	t <sub>a</sub>	$\label{eq:VGS} \begin{array}{l} V_{GS} = 0 \ V, \ d_{IS}/d_t = 100 \ A/\mu s, \\ I_S = 5.0 \ A \end{array}$			11.5		]
Discharge Time	t <sub>b</sub>				3.1		1
Reverse Recovery Charge	Q <sub>RR</sub>				11		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>	T <sub>A</sub> = 25°C			0.93		nH
Drain Inductance	L <sub>D</sub>				0.005		
Gate Inductance	L <sub>G</sub>				1.84		
Gate Resistance	R <sub>G</sub>				1.5		Ω

 $\begin{array}{ll} \text{5. Pulse Test: pulse width = 300 } \mu\text{s, duty cycle } \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$ 

#### **TYPICAL CHARACTERISTICS**



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Safe Operating Area

#### **TYPICAL CHARACTERISTICS**

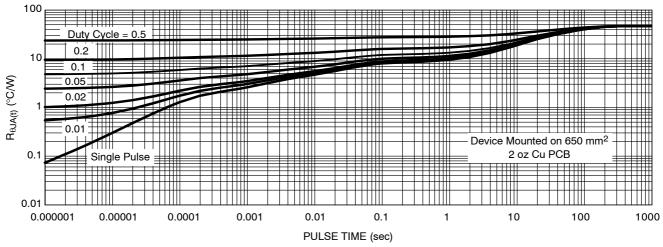
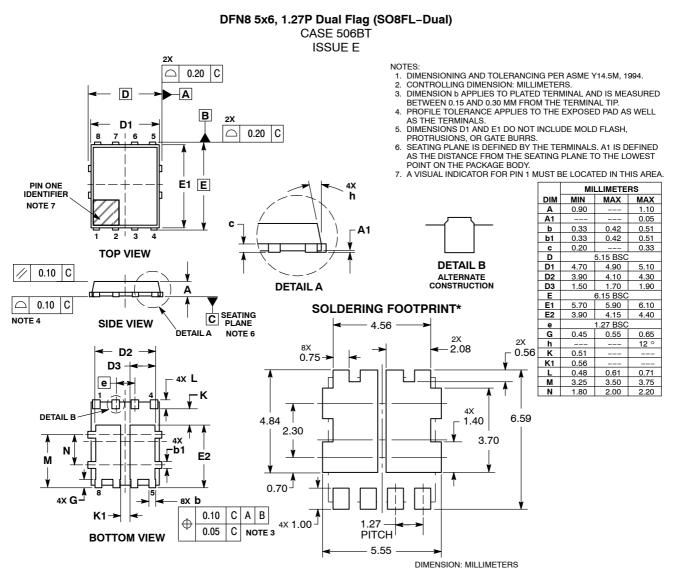


Figure 12. Thermal Response

#### PACKAGE DIMENSIONS



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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